

Exploiting Dual-Rail Register Invariants for Equivalence Verification of NCL Circuits

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Abstract—Equivalence checking is one of the most scalable and useful verification techniques in industry. NULL Convention Logic (NCL) circuits utilize dual-rail signals (i.e., two wires to represent one bit of DATA), where the wires are inverses of each other during a DATA wavefront. In this paper, a technique that exploits this invariant at NCL register boundaries is proposed to improve the efficiency of equivalence verification of NCL circuits.

Keywords—asynchronous circuits, formal verification, formal methods, equivalence checking, NULL Convention Logic

I. INTRODUCTION

NULL Convention Logic (NCL) [1] is one type of Quasi-Delay Insensitive (QDI) asynchronous circuit design paradigm, which has benefits over its synchronous counterpart by being more robust to process, voltage, and temperature (PVT) variations, allowing NCL circuits to operate in environments with extreme high or low temperatures, or with large temperature fluctuations, and with an ultra-low supply voltage [2]. Hence, NCL circuits are ideal candidates for applications in space exploration, the power industry, the automotive industry, oil/gas exploration, medical imaging instrumentation, the laser industry, superconducting computing and energy storage systems, and wireless sensor nodes or other low voltage or low power applications.

NCL circuits do not utilize a clock signal for synchronization, instead NCL utilizes multi-rail logic, such as dual-rail, along with a 4-phase handshaking protocol to achieve delay-insensitivity. A dual-rail signal, D , consists of two wires, D^0 and D^1 , which may assume any value from the set {DATA0, DATA1, NULL}. The DATA0 state ($D^0 = 1$ and $D^1 = 0$) corresponds to a Boolean logic 0, the DATA1 state ($D^0 = 0$ and $D^1 = 1$) corresponds to a Boolean logic 1, and the NULL state ($D^0 = 0$ and $D^1 = 0$) corresponds to the empty set meaning that the value of D is not yet available. The two rails are mutually exclusive, such that both rails can never be asserted simultaneously; this state is defined as an ILLEGAL state. Hence, when an NCL register is DATA, its rail¹ and rail⁰ outputs are inverses of each other, referred to herein as the Dual-Rail Register Invariant.

One of the very effective formal verification techniques for digital system design is equivalence checking. In commercial design cycles, the design is continuously optimized for performance, power, and area. Significant time and effort are invested in design testing. If the design is further optimized, it is not feasible to exhaustively test the design again. Equivalence checking has been found to be very effective to address this

problem as the verified design can be checked against the more optimized design directly. Equivalence checking has been previously extended to NCL circuits [3], where the NCL circuits are checked for equivalence against their synchronous counterparts. In this paper, the Dual-Rail Register Invariant is exploited to speed up the previous equivalence checking method for NCL circuits, which is demonstrated by using identical benchmarks to show the improvement in verification times.

II. RELATED WORK

In the NCL equivalence checking method presented in [3], the NCL netlist is first converted to a synchronous netlist. This conversion has three steps. First, the NCL threshold gates are replaced with their Boolean set function; and gate hysteresis is ignored. Second, rail¹ of each dual-rail input is replaced with a Boolean input; and each rail⁰ input is generated by negating its corresponding Boolean input. Third, the reset-to-NULL registers (henceforth termed as Reg_NULL) are removed, and their inputs connected directly to their outputs. Each dual-rail Reset-to-DATA register is replaced by a 2-bit synchronous register. Well Founded Equivalence Bisimulation (WEB) refinement [4] is used as the notion of equivalence to compare the synchronous version of the NCL circuit and the synchronous specification circuit. The WEB refinement property is checked using an SMT solver. This approach was found to be very scalable because the equivalence verification is performed at the synchronous-level instead of directly verifying the NCL circuit, which is difficult due to nondeterministic signal transitions in NCL circuits. Section III presents the proposed Dual-Rail Register Invariant technique that modifies the conversion technique described above for the register components to improve efficiency.

III. EQUIVALENCE VERIFICATION

The 3×3 unsigned NCL multiplier that implements the function $p(5:0) = xi(2:0) \times yi(2:0)$, as shown in Fig. 1 without its completion logic, will be used as the example circuit to show the circuit transformation done in the previous work and contrast that to the proposed Dual-Rail Register Invariant. It is comprised of several components including dual-rail inputs and outputs, input-complete NCL AND functions (represented with a C inside the AND symbol), input-incomplete NCL AND functions (represented with an I inside the AND symbol), NCL Half-Adders (HA) and Full-Adders (FA), and dual-rail Reset-to-NULL registers (REG_NULL).

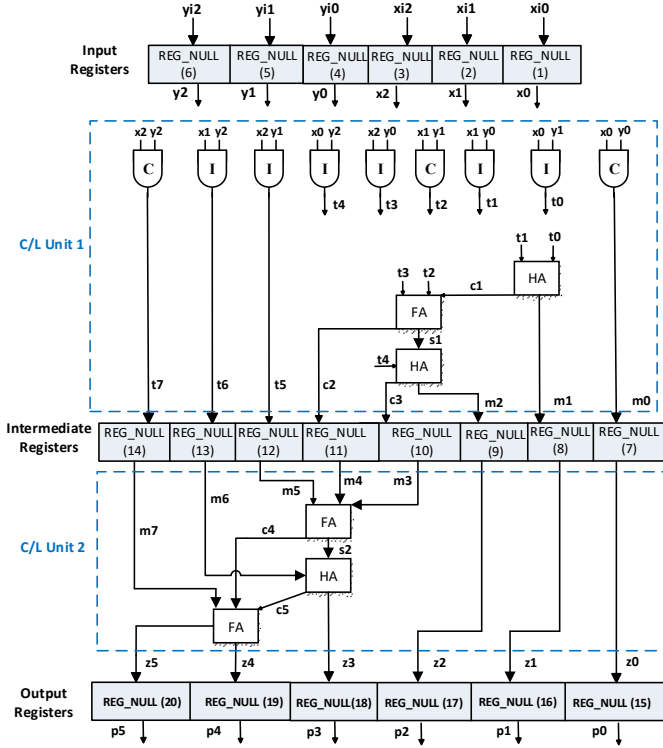


Fig. 1. 3x3 NCL multiplier circuit [3]

To accompany the circuit in Fig. 1, its netlist, and the netlist of the previous work's circuit transformation, are shown in Fig. 2(a) and 2(b), respectively. In Fig. 2(a), the first two lines indicate all primary inputs and primary outputs, respectively. Lines 3-44 correspond to the NCL C/L threshold gates, where the first column is the type of gate, the second column lists the gate's inputs, in comma separated format starting with input A , and the last column is the gate's output. Lines 45-64 correspond to 1-bit NCL registers, where the first column is the reset type of the register, the second column denotes the register's level (i.e., the depth of the path through registers without considering the C/L in-between; for the 3x3 multiplier example, there are 3 stages of registers, with levels 1, 2, and 3, starting from the input registers), the third and fourth columns are the register's rail⁰ and rail¹ data inputs, respectively, the fifth and sixth columns are the register's K_i input and K_o output, respectively, and the seventh and eighth columns are the register's rail⁰ and rail¹ data outputs, respectively. Lines 65-72 correspond to the C-elements (i.e., THnn gates) used in the handshaking control circuitry, where the first column is Cn, with n indicating the number of inputs to the C-element, the second column lists the inputs in comma separated format, and the last column is the C-element's output.

A. Previous Circuit Transformation

For Fig. 2(b), each NCL gate from Fig. 2(a) is replaced with its corresponding Boolean gate without hysteresis, and the dual-rail primary inputs are replaced by their respective rail¹ input, which are then complemented by inserting invertors (lines 3-8) to generate their corresponding rail⁰ signals. The Reg_NULL

components are removed by connecting their inputs to their outputs; and the handshaking C-elements are also removed.

B. Proposed Dual-Rail Register Invariant

Instead of removing the Reg_NULL components by connecting their inputs to their outputs, the proposed Dual-Rail Register Invariant removes the Reg_NULL components by connecting their rail¹ inputs to their corresponding rail¹ outputs, and then generates each rail⁰ output by inverting its corresponding rail¹ input. This transformation is possible due to the inherent NCL property where the rail¹ and rail⁰ values are inverses of each other in the DATA phase. Note that both this inverse signal property and correctness of the NULL phase are checked as part of the NCL formal verification method presented in [3]. The proposed Dual-Rail Register Invariant allows the SMT solver to trim the circuit by removing all logic solely used to generate the Reg_NULL rail⁰ inputs, replacing this instead with a single inverter, as shown in Fig. 2(c).

C. Proof Obligation

The proof obligation for equivalence verification is the same for the original approach and the proposed approach that exploits the Dual-Rail Register Invariant. We now describe the proof obligation. Consider an NCL circuit with p inputs and q outputs. Note that NCL inputs and outputs are dual-rail. The corresponding synchronous circuit will have p Boolean inputs and q Boolean outputs. We step both the specification synchronous circuit and the NCL-reduced synchronous circuit, with the same symbolic inputs i^1, \dots, i^p , to generate outputs $O_{sync}^1, \dots, O_{sync}^q$, and $O_{NCL}^1, \dots, O_{NCL}^q$, respectively. The proof obligation itself is constructed using the predicates from Table 1: $\{p_0 \wedge p_1\} \rightarrow p_2$. p_0 corresponds to the symbolic step of the NCL reduced synchronous circuit, and p_1 corresponds to the symbolic step of the synchronous specification circuit. p_2 is the equivalence predicate, which states that the rail¹'s of the NCL reduced synchronous outputs should be equal to the synchronous specification circuit outputs.

IV. RESULTS

For comparison, the same unsigned NCL Multiply and Accumulate (MAC) circuits as in [3], with increasing operand sizes to show scalability, were used. These implement the function $acci = acci + xi \times yi$, as shown in Fig. 3 for a 4+2x2 NCL MAC, without its completion logic. As shown in the Fig. 3 example, each MAC's C/L is partitioned into 2 stages by inserting a Reset-to-NULL register between the last carry-save adder and the final ripple-carry adder; and the feedback loop

TABLE I. EQUIVALENCE CHECKING PREDICATES

p_n	Predicate
p_0	$(O_{NCL}^1, \dots, O_{NCL}^q) = NCLStep(i^1, \dots, i^p)$
p_1	$(O_{sync}^1, \dots, O_{sync}^q) = SyncStep(i^1, \dots, i^p)$
p_2	$\bigwedge_{n=1}^{n=q} (rail1(o_{NCL}^n) = o_{sync}^n)$

1. xi0_0,xi0_1,xi1_0,xi1_1, ..., yi1_0,yi1_1,yi2_0,yi2_1 2. p0_0,p0_1,p1_0,p1_1,...,p5_0,p5_1 3. th22 x0_1,y0_1 m0_1 4. thand0 y0_0,x0_0,y0_1,x0_1 m0_0 5. th22 x0_1,y1_1 t0_1 6. th12 x0_0,y1_0 t0_0 7. th22 x0_1,y2_1 t4_1 8. th12 x0_0,y2_0 t4_0 9. th22 x1_1,y0_1 t1_1 10. th12 x1_0,y0_0 t1_0 11. th22 x1_1,y1_1 t2_1 12. thand0 y1_0,x1_0,y1_1,x1_1 t2_0 13. th22 x1_1,y2_1 t6_1 14. th12 x1_0,y2_0 t6_0 15. th22 x2_1,y0_1 t3_1 16. th12 x2_0,y0_0 t3_0 17. th22 x2_1,y1_1 t5_1 18. th12 x2_0,y1_0 t5_0 19. th22 x2_1,y2_1 t7_1 20. thand0 y2_0,x2_0,y2_1,x2_1 t7_0 21. th24comp t0_0,t1_0,t0_1,t1_1 m1_1 22. th24comp t0_0,t1_1,t1_0,t0_1 m1_0 23. th22 t0_1,t1_1 c1_1 24. th12 t0_0,t1_0 c1_0 25. th23 t3_0,t2_0,c1_0 c2_0 26. th23 t3_1,t2_1,c1_1 c2_1 27. th34w2 c2_0,t3_1,t2_1,c1_1 s1_1 28. th34w2 c2_1,t3_0,t2_0,c1_0 s1_0 29. th24comp s1_0,t4_0,s1_1,t4_1 m2_1 30. th24comp s1_0,t4_1,t4_0,s1_1 m2_0 31. th22 s1_1,t4_1 c3_1 32. th12 s1_0,t4_0 c3_0 33. th23 m5_0,m4_0,m3_0 c4_0 34. th23 m5_1,m4_1,m3_1 c4_1 35. th34w2 c4_0,m5_1,m4_1,m3_1 s2_1 36. th34w2 c4_1,m5_0,m4_0,m3_0 s2_0 37. th24comp s2_0,m6_0,s2_1,m6_1 z3_1 38. th24comp s2_0,m6_1,m6_0,s2_1 z3_0 39. th22 s2_1,m6_1 c5_1 40. th12 s2_0,m6_0 c5_0 41. th23 m7_0,c4_0,c5_0 z5_0 42. th23 m7_1,c4_1,c5_1 z5_1 43. th34w2 z5_0,m7_1,c4_1,c5_1 z4_1 44. th34w2 z5_1,m7_0,c4_0,c5_0 z4_0 45. Reg.NULL 1 xi0_0,xi0_1 K03 ko1 x0_0,x0_1 46. Reg.NULL 1 xi1_0,xi1_1 K03 ko2 x1_0,x1_1 47. Reg.NULL 1 xi2_0,xi2_1 K03 ko3 x2_0,x2_1 48. Reg.NULL 1 yi0_0,yi0_1 K03 ko4 y0_0,y0_1 49. Reg.NULL 1 yi1_0,yi1_1 K03 ko5 y1_0,y1_1 50. Reg.NULL 1 yi2_0,yi2_1 K03 ko6 y2_0,y2_1 51. Reg.NULL 2 m0_0,m0_1 ko15 ko7 z0_0,z0_1 52. Reg.NULL 2 m1_0,m1_1 ko16 ko8 z1_0,z1_1 53. Reg.NULL 2 m2_0,m2_1 ko17 ko9 z2_0,z2_1 54. Reg.NULL 2 c3_0,c3_1 K04 ko10 m3_0,m3_1 55. Reg.NULL 2 c2_0,c2_1 K04 ko11 m4_0,m4_1 56. Reg.NULL 2 t5_0,t5_1 K04 ko12 m5_0,m5_1 57. Reg.NULL 2 t6_0,t6_1 K04 ko13 m6_0,m6_1 58. Reg.NULL 2 t7_0,t7_1 K05 ko14 m7_0,m7_1 59. Reg.NULL 3 z0_0,z0_1 Ki ko15 p0_0,p0_1 60. Reg.NULL 3 z1_0,z1_1 Ki ko16 p1_0,p1_1 61. Reg.NULL 3 z2_0,z2_1 Ki ko17 p2_0,p2_1 62. Reg.NULL 3 z3_0,z3_1 Ki ko18 p3_0,p3_1 63. Reg.NULL 3 z4_0,z4_1 Ki ko19 p4_0,p4_1 64. Reg.NULL 3 z5_0,z5_1 Ki ko20 p5_0,p5_1 65. C4 ko7,ko8,ko9,ko10 K01 66. C4 ko11,ko12,ko13,ko14 K02 67. C2 K01,K02 K03 68. C3 ko18,ko19,ko20 K04 69. C2 ko19,ko20 K05 70. C3 ko4,ko5,ko6 K06 71. C3 ko1,ko2,ko3 K07 72. C2 K07,K06 K0	1. xi0_1,xi1_1,xi2_1,yi0_1,yi1_1,yi2_1 2. p0_0,p0_1,p1_0,p1_1,...,p5_0,p5_1 3. not xi0_1 xi0_0 4. not xi1_1 xi1_0 5. not xi2_1 xi2_0 6. not yi0_1 yi0_0 7. not yi1_1 yi1_0 8. not yi2_1 yi2_0 9. th22 xi0_1,yi0_1 p0_1 10. thand0 yi0_0,xi0_0,yi0_1,xi0_1 p0_0 11. th22 xi0_1,yi1_1 t0_1 12. th12 xi0_0,yi1_0 t0_0 13. th22 xi0_1,yi2_1 t4_1 14. th12 xi0_0,yi2_0 t4_0 15. th22 xi1_1,yi0_1 t1_1 16. th12 xi1_0,yi0_0 t1_0 17. th22 xi1_1,yi1_1 t2_1 18. thand0 yi1_0,xi1_0,yi1_1,xi1_1 t2_0 19. th22 xi1_1,yi2_1 t6_1 20. th12 xi1_0,yi2_0 t6_0 21. th22 xi2_1,yi0_1 t3_1 22. th12 xi2_0,yi0_0 t3_0 23. th22 xi2_1,yi1_1 t5_1 24. th12 xi2_0,yi1_0 t5_0 25. th22 xi2_1,yi2_1 t7_1 26. thand0 yi2_0,xi2_0,yi2_1,xi2_1 t7_0 27. th24comp t0_0,t1_0,t0_1,t1_1 p1_1 28. th24comp t0_0,t1_1,t1_0,t0_1 p1_0 29. th22 t0_1,t1_1 c1_1 30. th12 t0_0,t1_0 c1_0 31. th23 t3_0,t2_0,c1_0 c2_0 32. th23 t3_1,t2_1,c1_1 c2_1 33. th34w2 c2_0,t3_1,t2_1,c1_1 s1_1 34. th34w2 c2_1,t3_0,t2_0,c1_0 s1_0 35. th24comp s1_0,t4_0,s1_1,t4_1 p2_1 36. th24comp s1_0,t4_1,t4_0,s1_1 p2_0 37. th22 s1_1,t4_1 c3_1 38. th12 s1_0,t4_0 c3_0 39. th23 t5_0,c2_0,c3_0 c4_0 40. th23 t5_1,c2_1,c3_1 c4_1 41. th34w2 c4_0,t5_1,c2_1,c3_1 s2_1 42. th34w2 c4_1,t5_0,c2_0,c3_0 s2_0 43. th24comp s2_0,t6_0,s2_1,t6_1 p3_1 44. th24comp s2_0,t6_1,t6_0,s2_1 p3_0 45. th22 s2_1,t6_1 c5_1 46. th12 s2_0,t6_0 c5_0 47. th23 t7_0,c4_0,c5_0 p5_0 48. th23 t7_1,c4_1,c5_1 p5_1 49. th34w2 p5_0,t7_1,c4_1,c5_1 p4_1 50. th34w2 p5_1,t7_0,c4_0,c5_0 p4_0	1. xi0_1,xi1_1,xi2_1,yi0_1,yi1_1,yi2_1 2. p0_0,p0_1,p1_0,p1_1,...,p5_0,p5_1 3. not xi0_1 xi0_0 4. not xi1_1 xi1_0 5. not xi2_1 xi2_0 6. not yi0_1 yi0_0 7. not yi1_1 yi1_0 8. not yi2_1 yi2_0 9. th22 xi0_1,yi0_1 p0_1 10. not p0_1 p0_0 11. th22 xi0_1,yi1_1 t0_1 12. th12 xi0_0,yi1_0 t0_0 13. th22 xi0_1,yi2_1 t4_1 14. th12 xi0_0,yi2_0 t4_0 15. th22 xi1_1,yi0_1 t1_1 16. th12 xi1_0,yi0_0 t1_0 17. th22 xi1_1,yi1_1 t2_1 18. thand0 yi1_0,xi1_0,yi1_1,xi1_1 t2_0 19. th22 xi1_1,yi2_1 t6_1 20. not t6_1 t6_0 21. th22 xi2_1,yi0_1 t3_1 22. th12 xi2_0,yi0_0 t3_0 23. th22 xi2_1,yi1_1 t5_1 24. not t5_1 t5_0 25. th22 xi2_1,yi2_1 t7_1 26. not t7_1 t7_0 27. th24comp t0_0,t1_0,t0_1,t1_1 p1_1 28. not p1_1 p1_0 29. th22 t0_1,t1_1 c1_1 30. th12 t0_0,t1_0 c1_0 31. th23 t3_1,t2_1,c1_1 c2_1 32. not c2_1 c2_0 33. th34w2 c2_0,t3_1,t2_1,c1_1 s1_1 34. th34w2 c2_1,t3_0,t2_0,c1_0 s1_0 35. th24comp s1_0,t4_0,s1_1,t4_1 p2_1 36. not p2_1 p2_0 37. th22 s1_1,t4_1 c3_1 38. not c3_1 c3_0 38. th12 s1_0,t4_0 c3_0 39. th23 t5_0,c2_0,c3_0 c4_0 40. th23 t5_1,c2_1,c3_1 c4_1 41. th34w2 c4_0,t5_1,c2_1,c3_1 s2_1 42. th34w2 c4_1,t5_0,c2_0,c3_0 s2_0 43. th24comp s2_0,t6_0,s2_1,t6_1 p3_1 44. not p3_1 p3_0 45. th22 s2_1,t6_1 c5_1 46. th12 s2_0,t6_0 c5_0 47. th23 t7_1,c4_1,c5_1 p5_1 48. not p5_1 p5_0 49. th34w2 p5_0,t7_1,c4_1,c5_1 p4_1 50. not p4_1 p4_0
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(a)

(b)

(c)

Fig. 2. (a) 3×3 NCL multiplier netlist (b) converted netlist using method in [3] (c) converted netlist using proposed Dual-Rail Register Invariant

TABLE II. VERIFICATION RESULTS

Circuit	Speedup
$8 + 4 \times 4 \text{ MAC}$	1.14
$12 + 6 \times 6 \text{ MAC}$	1.17
$16 + 8 \times 8 \text{ MAC}$	2.75
$20 + 10 \times 10 \text{ MAC}$	1.31
$22 + 11 \times 11 \text{ MAC}$	3.63
$24 + 12 \times 12 \text{ MAC}$	TO/67,599 sec
$16 + 8 \times 8 \text{ MAC} - 5 \text{ Reg}$	3.44
$20 + 10 \times 10 \text{ MAC} - 5 \text{ Reg}$	1.46

contains 4 registers for increased performance. Note that the proposed Dual-Rail Register Invariant can also be applied to Reset-to-DATA registers, resulting in their replacement with a single synchronous register, plus an inverter to generate the rail⁰ output, instead of the previous conversion technique that required 2 synchronous registers, as described in Section II.

The Z3 SMT solver [5] was used to check for equivalence, but any combinational equivalence checker could be used. Table II lists the verification results, where the first column indicates the MAC size, and the second column is speedup (i.e., equivalence verification time using the method described in [3] divided by equivalence verification time using the proposed Dual-Rail Register Invariant). Timeout (TO) denotes that the verification time exceeded one day. The last 2 rows in Table II are for MACs with an additional Reset-to-NULL register inserted between the partial product generation circuitry (i.e., AND functions) and the first carry-save adder.

The results show speedups ranging from 14% - 263% for the various 4-register MACs, and an additional speedup of 25% and 11% when adding an extra 5th register stage in the $16+8 \times 8$

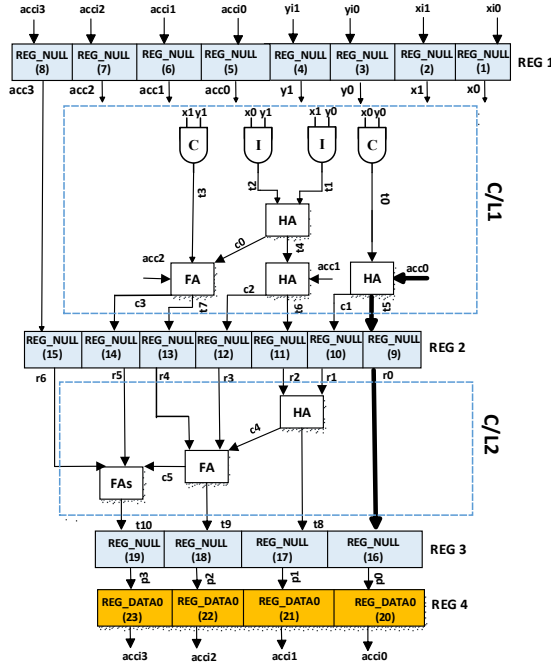


Fig. 3. 4+2x2 NCL MAC [3]

and $20+10 \times 10$ MACs, respectively. Note that the $24+12 \times 12$ MAC timed out using the previous approach in [3], but was successfully verified in less than 1 day utilizing the proposed Dual-Rail Register Invariant.

V. CONCLUSIONS AND FUTURE WORK

This paper proposes the Dual-Rail Register Invariant technique to speedup equivalence checking of NCL circuit implementations with respect to their Boolean/synchronous specifications. It has been shown to significantly reduce equivalence checking times, and to further speedup equivalence checking when additional pipeline stages are added to the NCL circuit, as this allows for more usage of the technique.

The proposed Dual-Rail Register Invariant technique is also applicable to speedup equivalence verification of Sleep Convention Logic (SCL) circuits [6], as the circuit transformation and safety verification are the same for SCL and NCL, only liveness verification differs [7].

Future work includes investigating additional refinements and invariants to potentially further reduce verification time, such as applying the dual-rail invariant described herein, to generate rail⁰ as the inverse of rail¹, at the outputs of every NCL C/L function (e.g., HA, FA, AND), instead of only at register boundaries. This would require NCL C/L functions to be reconstructed from a flattened NCL gate netlist, where the two wires of a dual-rail signal are disassociated. Additionally, the invariant check from [3], which ensures that the rail¹ and rail⁰ outputs of each NCL register are always inverses of each other during the DATA phase, would also need to be checked at the output of each NCL C/L function, instead of only at the register boundaries.

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